

Notice of References Cited	Application/Control No. 10/706,050	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner HOAN C. NGUYEN	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0174262 A1	09-2003	Sugawara et al.	349/65
*	B	US-7,019,714 B2	03-2006	Uchida et al.	345/3.1
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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